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FDD3580/FDU3580

80V N-Channel PowerTrench® MOSFET

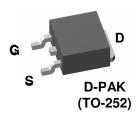
General Description

This N-Channel MOSFET has been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers.

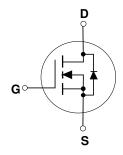
This MOSFET features faster switching and lower gate change than other MOSFETs with comparable $R_{\text{DS}(\text{ON})}$ specifications resulting in DC/DC power supply designs with higher overall efficiency.

Features

- 7.7 A, 80 V. $R_{DS(ON)} = 29 \text{ m}\Omega$ @ $V_{GS} = 10 \text{ V}$ $R_{DS(ON)} = 33 \text{ m}\Omega$ @ $V_{GS} = 6 \text{ V}$
- Low gate charge (34nC typical)
- · Fast switching speed
- High performance trench technology for extremely low R_{DS(ON)}
- · High power and current handling capability







Absolute Maximum Ratings

T_A=25°C unless otherwise noted

Symbol	Parameter	Ratings	Units
V _{DSS}	Drain-Source Voltage	80	V
V _{GSS}	Gate-Source Voltage	± 20	V
I _D	Maximum Drain Current-Continuous (Note 1a)	7.7	Α
	Maximum Drain Current – Pulsed	50	
P _D	Maximum Power Dissipation @T _C = 25°C (Note 1)	42	W
	$T_A = 25^{\circ}C$ (Note 1a)	3.8	
	$T_A = 25^{\circ}C$ (Note 1b)	1.6	
T _J , T _{STG}	Operating and Storage Junction Temperature Range	−55 to +175	°C

Thermal Characteristics

R _{θJC}	Thermal Resistance, Junction-to- Case	(Note 1)	3.5	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to- Ambient	(Note 1b)	96	°C/W

Package Marking and Ordering Information

Device Marking	Device	Reel Size	Tape width	Quantity
FDD3580	FDD3580	13"	16mm	2500
FDU3580	FDU3580	Tube	N/A	75

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Drain-Sou	urce Avalanche Ratings (Note 2	2)	u.			
W _{DSS}	Single Pulse Drain-Source Avalanche Energy	$V_{DD} = 40 \text{ V}, I_D = 7.7 \text{ A}$			245	mJ
I _{AR}	Maximum Drain-Source Avalanche Current				7.7	Α
Off Chara	ecteristics					
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, \qquad I_{D} = 250 \mu\text{A}$	80			V
$\Delta BV_{DSS} \over \Delta T_{,l}$	Breakdown Voltage Temperature Coefficient	I_D = 250 μ A, Referenced to 25°C		79		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 64 \text{ V}, V_{GS} = 0 \text{ V}$			1	μΑ
I _{GSSF}	Gate-Body Leakage, Forward	V _{GS} = 20 V, V _{DS} = 0 V			100	nA
I _{GSSR}	Gate-Body Leakage, Reverse	$V_{GS} = -20 \text{ V}, \ V_{DS} = 0 \text{ V}$			-100	nA
On Chara	icteristics (Note 2)					
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$	2	2.5	4	V
$\Delta V_{GS(th)} \over \Delta T_{,l}$	Gate Threshold Voltage Temperature Coefficient	I_D = 250 μ A, Referenced to 25°C		-7		mV/°C
R _{DS(on)}	Static Drain–Source On–Resistance	$V_{GS} = 10 \text{ V}, I_D = 7.7 \text{ A}$ $V_{GS} = 6 \text{ V}, I_D = 7.2 \text{ A}$ $V_{GS} = 10 \text{ V}, I_D = 7.7 \text{ A}, T_J = 125 ^{\circ}\text{C}$		23 24 37	29 33 50	mΩ
I _{D(on)}	On-State Drain Current	$V_{GS} = 10 \text{ V}, V_{DS} = 10 \text{ V}$	30			Α
g _{FS}	Forward Transconductance	$V_{DS} = 10 \text{ V}, I_{D} = 7.7 \text{ A}$		28		S
Dynamic	Characteristics					
C _{iss}	Input Capacitance	$V_{DS} = 40 \text{ V}, V_{GS} = 0 \text{ V},$		1760		pF
Coss	Output Capacitance	f = 1.0 MHz		144		pF
C _{rss}	Reverse Transfer Capacitance			72		pF
Switching	g Characteristics (Note 2)					
t _{d(on)}	Turn-On Delay Time	$V_{DD} = 40 \text{ V}, I_{D} = 1 \text{ A},$		13	23	ns
t _r	Turn-On Rise Time	$V_{GS} = 10 \text{ V}, R_{GEN} = 6 \Omega$		8	16	ns
t _{d(off)}	Turn-Off Delay Time			34	54	ns
t _f	Turn-Off Fall Time			16	29	ns
Q _g	Total Gate Charge	$V_{DS} = 40V$, $I_{D} = 7.7 A$,		35	49	nC
Q _{gs}	Gate-Source Charge	$V_{GS} = 10 V$,	<u> </u>	6.2		nC
Q_{gd}	Gate-Drain Charge			8.6		nC
Drain-So	urce Diode Characteristics a	and Maximum Ratings				
Is	Maximum Continuous Drain-Sourc				3.2	Α
V _{SD}	Drain-Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_S = 3.2 \text{ A}$ (Note 2)		0.73	1.2	V

Notes:

 R_{BJA} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{BJC} is guaranteed by design while R_{BCA} is determined by the user's board design.



a) $R_{\theta,JA} = 40 \, ^{\circ}\text{C/W}$ when mounted on a $1 \, \text{in}^2$ pad of 2 oz copper.



b) $R_{\theta JA} = 96 \, ^{\circ}\text{C/W}$ when mounted on a minimum pad.

Scale 1 : 1 on letter size paper

2. Pulse Test: Pulse Width < 300 μ s, Duty Cycle < 2.0%

Typical Characteristics

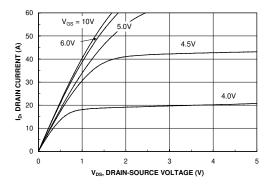


Figure 1. On-Region Characteristics.

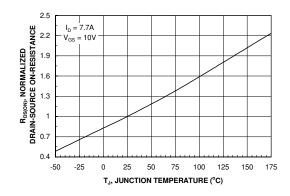


Figure 3. On-Resistance Variation with Temperature.

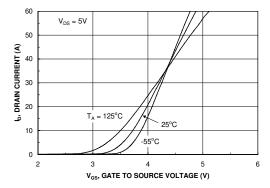


Figure 5. Transfer Characteristics.

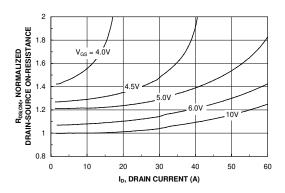


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

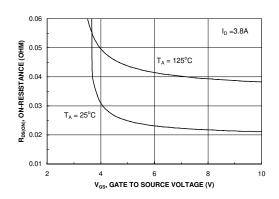


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

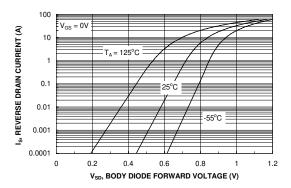
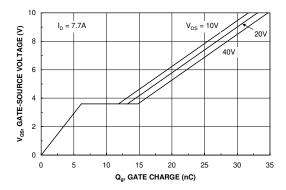


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

Typical Characteristics



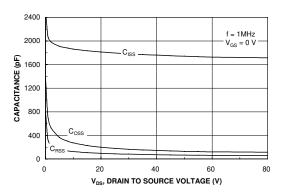


Figure 7. Gate Charge Characteristics.

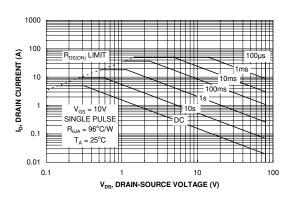


Figure 8. Capacitance Characteristics.

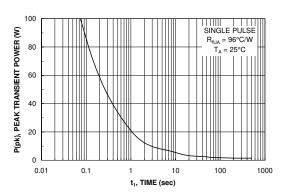


Figure 9. Maximum Safe Operating Area.



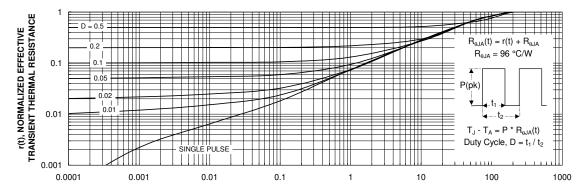


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1b. Transient thermal response will change depending on the circuit board design.

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